



RADIO TEST REPORT

Test Report No. : 13140333H-F-R1

Applicant : Nikon Corporation
Type of EUT : Wireless Remote Controller
Model Number of EUT : NC-TRMOD24
FCC ID : CGJ4156EC
Test regulation : FCC Part 15 Subpart C: 2020
Test Result : Complied (Refer to SECTION 3.2)

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the limits of the above regulation.
4. The test results in this test report are traceable to the national or international standards.
5. This test report covers Radio technical requirements.
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
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7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S Government.
8. The information provided from the customer for this report is identified in SECTION 1.
9. This report is a revised version of 13140333H-F. 13140333H-F is replaced with this report.

Date of test: February 18 to 28, 2020

Representative test engineer:


Yuta Moriya
Engineer
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Approved by:


Satofumi Matsuyama
Engineer
Consumer Technology Division



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REVISION HISTORY

Original Test Report No.: 13140333H-F

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13140333H-F	May 18, 2020	-	-
1	13140333H-F-R1	July 9, 2020	P.10	Correction of supplied voltage from AC 100 V / 60 Hz to AC 120 V / 60 Hz
1	13140333H-F-R1	July 9, 2020	P.10	Correction of Shield of USB Cable from Unshielded to Shielded
1	13140333H-F-R1	July 9, 2020	P.17	Correction of 6 dB Bandwidth data.
1	13140333H-F-R1	July 9, 2020	P.21	Deletion of sentence below the table.

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name	:	Nikon Corporation
Address	:	Shinagawa Intercity Tower C, 2-15-3, Konan, Minato-ku, Tokyo 108-6290, Japan
Telephone Number	:	+81-3-6433-3600
Facsimile Number	:	+81-3-6433-3781
Contact Person	:	Tatsuzo Kudoh

The information provided from the customer is as follows;

- Applicant, Type of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (EUT)
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Type of Equipment	:	Wireless Remote Controller
Model No.	:	NC-TRMOD24
Serial No.	:	Refer to SECTION 4.2
Rating	:	DC 3 V - 7 V
Receipt Date of Sample (Information from test lab.)	:	February 10, 2020
Country of Mass-production	:	Japan
Condition of EUT	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab.

2.2 Product Description

Model: NC-TRMOD24 (referred to as the EUT in this report) is a Wireless Remote Controller.

Radio Specification

Radio Type	:	Transceiver
Frequency of Operation	:	2425 MHz to 2475 MHz
Modulation	:	O-QPSK
Antenna type	:	1/4 wave dipole antenna
Antenna Gain	:	2.0 dBi
Clock frequency (Maximum)	:	32 MHz

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on April 1, 2020 and effective June 1, 2020 except 15.258

Title : FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz,
and 5725-5850 MHz

* The revision does not affect the test result conducted before its effective date.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods ISED: RSS-Gen 8.8	FCC: Section 15.207 ISED: RSS-Gen 8.8	15.65 MHz 3.73040 MHz, AV, N	Complied a)	-
6dB Bandwidth	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section 15.247(a)(2) ISED: RSS-247 5.2(a)	See data.	Complied b)	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.12	FCC: Section 15.247(b)(3) ISED: RSS-247 5.4(d)		Complied c)	Conducted
Power Density	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: -	FCC: Section 15.247(e) ISED: RSS-247 5.2(b)		Complied d)	Conducted
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02 ISED: RSS-Gen 6.13	FCC: Section 15.247(d) ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	7.4 dB 40.000 MHz, QP, Hori.	Complied e), f)	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *1)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 15.247 Meas Guidance v05r02 8.5 and 8.6.

- a) Refer to APPENDIX 1 (data of Conducted Emission)
- b) Refer to APPENDIX 1 (data of 6 dB Bandwidth and 99 % Occupied Bandwidth)
- c) Refer to APPENDIX 1 (data of Maximum Peak Output Power)
- d) Refer to APPENDIX 1 (data of Power Density)
- e) Refer to APPENDIX 1 (data of Conducted Spurious Emission)
- f) Refer to APPENDIX 1 (data of Radiated Spurious Emission)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

This EUT provides the stable voltage constantly to RF module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203/212 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	RSS-Gen 6.7	ISED: -	N/A	- a)	Conducted
a) Refer to APPENDIX 1 (data of 6 dB Bandwidth and 99 % Occupied Bandwidth)					

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.
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Antenna Terminal test

Test Item	Uncertainty (+/-)
20 dB Bandwidth / 99 % Occupied Bandwidth	0.96 %
Maximum Peak Output Power / Average Output Power	1.4 dB
Carrier Frequency Separation	0.42 %
Dwell time / Burst rate	0.10 %
Conducted Spurious Emission	2.6 dB

Conducted emission

using Item	Frequency range	Uncertainty (+/-)
AMN (LISN)	0.009 MHz to 0.15 MHz	3.4 dB
	0.15 MHz to 30 MHz	2.9 dB

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		4.8 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.0 dB
		5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB
	6 GHz to 18 GHz	5.2 dB
1 m	10 GHz to 26.5 GHz	5.5 dB
	26.5 GHz to 40 GHz	5.5 dB
10 m	1 GHz to 18 GHz	5.2 dB

3.5 Test Location

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*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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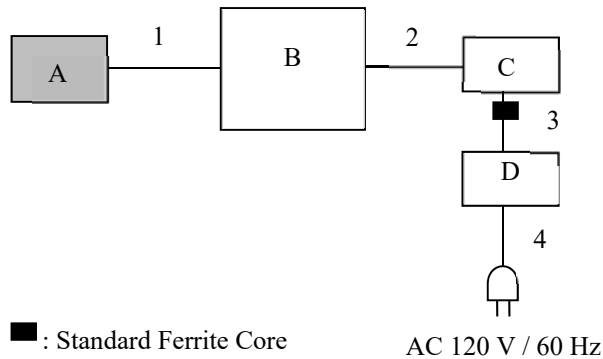
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SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	Tested frequency
Transmitting (Tx)	2425 MHz 2450 MHz 2475 MHz
*Transmitting duty was 100 % on all tests.	
*Power of the EUT was set by the software as follows; - Power Setting: 8 dBm - Software: SCE2 Version 2.3.49 (Date: February 18, 2020, Storage location: Driven by connected PC) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Wireless Remote Controller	NC-TRMOD24	Z00017 *1) Z00018 *2)	Nikon Corporation	EUT
B	Jig	-	-	-	-
C	Laptop PC	X1 Carbon	R9-OH8OBW 15/9	Lenovo	-
D	AC Adapter	ADLX45NCC2A	8SSA10E75794C1SG59R0GHF	Lenovo	-

List of cables used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	Signal Cable	3.15	Unshielded	Unshielded	-
2	USB Cable	3.0	Shielded	Shielded	-
3	DC Cable	1.7	Unshielded	Unshielded	-
4	AC Cable	1.0	Unshielded	Unshielded	-

*1) for Conducted emission and Radiated emission (Below 1 GHz)

*2) for Radiated emission (Above 1 GHz) and Antenna Terminal Conducted tests)

SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

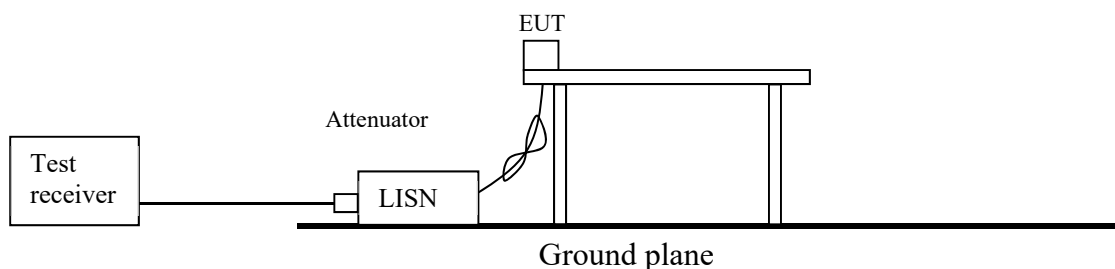
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement range	: 0.15 MHz - 30 MHz
Test data	: APPENDIX
Test result	: Pass

Figure 1: Test Setup



SECTION 6: Radiated Spurious Emission

Test Procedure

It was measured based on "8.5 and 8.6 of KDB 558074 D01 15.247 Meas Guidance v05r02".

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	11.12.2.5.1 RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces 11.12.2.5.2 The duty cycle was less than 98% for detected noise, a duty factor was added to the 11.12.2.5.1 results.	RBW: 100 kHz VBW: 300 kHz

*1) Average Power Measurement was performed based on ANSI C63.10-2013.

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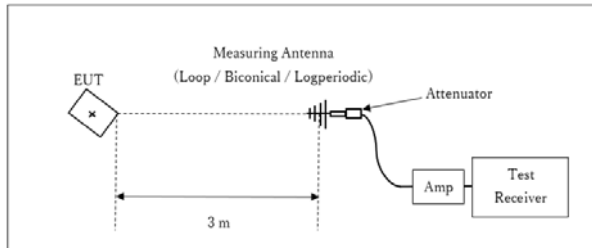
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Figure 2: Test Setup

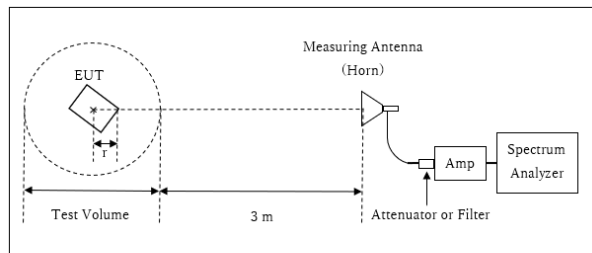
Below 1 GHz



x : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT

x : Center of turn table

Distance Factor: $20 \times \log (4.0 \text{ m} / 3.0 \text{ m}) = 2.5 \text{ dB}$

* Test Distance: $(3 + \text{Test Volume} / 2) - r = 4.0 \text{ m}$

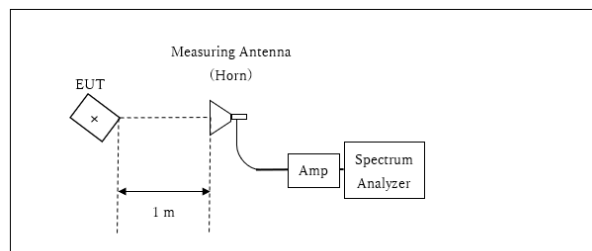
Test Volume : 2.0 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

r = 0.0 m

* The test was performed with r = 0.0 m since EUT is small and it was the rather conservative condition.

10 GHz - 26.5 GHz



x : Center of turn table

Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

*Test Distance: 1 m

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30 MHz - 26.5 GHz

Test data : APPENDIX

Test result : Pass

SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	3 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/ Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	10 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	9.1 kHz	27 kHz				
*1) Peak hold was applied as Worst-case measurement.							
*2) Reference data							
*3) Section 11.10.2 Method PKPSD (peak PSD) of "ANSI C63.10-2013".							
*4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.							
Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.							
(9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 9.1 kHz)							

The test results and limit are rounded off to two decimals place, so some differences might be observed.
 The equipment and cables were not used for factor 0 dB of the data sheets.

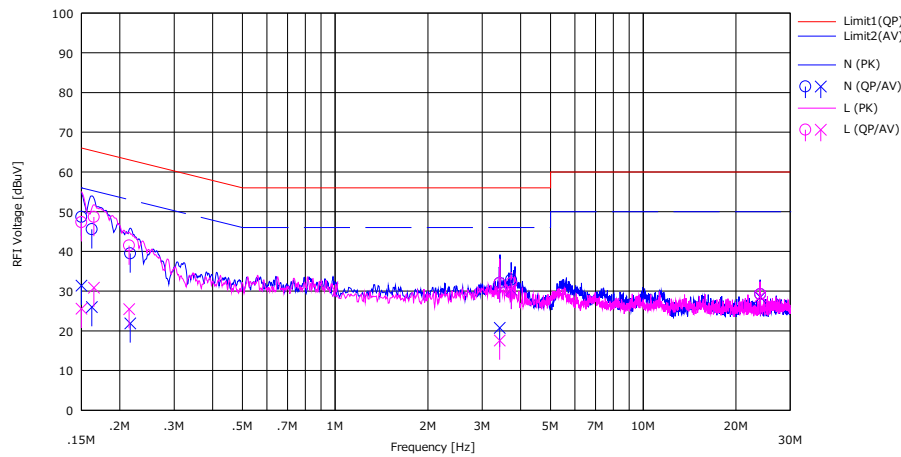
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

Conducted Emission

Report No. 13140333H
Test place Ise EMC Lab. No.4 Semi Anechoic Chamber
Date February 28, 2020
Temperature / Humidity 23 deg. C / 28 % RH
Engineer Yuta Moriya
Mode Tx 2425 MHz

Limit : FCC_Part 15 Subpart C(15.207)



No.	Freq. [MHz]	Reading		LISN [dB]	LOSS [dB]	Results		Limit		Margin		Phase	Comment
		(QP) [dBuV]	(AV) [dBuV]			(QP) [dBuV]	(AV) [dBuV]	(QP) [dBuV]	(AV) [dBuV]	(QP) [dB]	(AV) [dB]		
1	0.15000	35.21	17.90	0.07	13.38	48.66	31.35	66.00	56.00	17.34	24.65	N	
2	0.16218	32.10	12.50	0.07	13.38	45.55	25.95	65.40	55.40	19.85	29.45	N	
3	0.21612	26.00	8.40	0.07	13.39	39.46	21.86	63.00	53.00	23.54	31.14	N	
4	3.42120	18.30	7.00	0.12	13.62	32.04	20.74	56.00	46.00	23.96	25.26	N	
5	3.73040	19.10	16.60	0.12	13.63	32.85	30.35	56.00	46.00	23.15	15.65	N	
6	24.00900	14.50	13.80	0.49	14.18	29.17	28.47	60.00	50.00	30.83	21.53	N	
7	0.15000	33.90	12.10	0.07	13.38	47.35	25.55	66.00	56.00	18.65	30.45	L	
8	0.16479	35.20	17.40	0.07	13.38	48.65	30.85	65.20	55.20	16.55	24.35	L	
9	0.21438	28.00	12.00	0.07	13.39	41.46	25.46	63.00	53.00	21.54	27.54	L	
10	3.42120	18.20	3.80	0.13	13.62	31.95	17.55	56.00	46.00	24.05	28.45	L	
11	3.73040	18.20	16.50	0.13	13.63	31.96	30.26	56.00	46.00	24.04	15.74	L	
12	24.00900	14.40	13.90	0.59	14.18	29.17	28.67	60.00	50.00	30.83	21.33	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + C.F (LISN + CABLE + ATT)
Except for the above table: adequate margin data below the limits.

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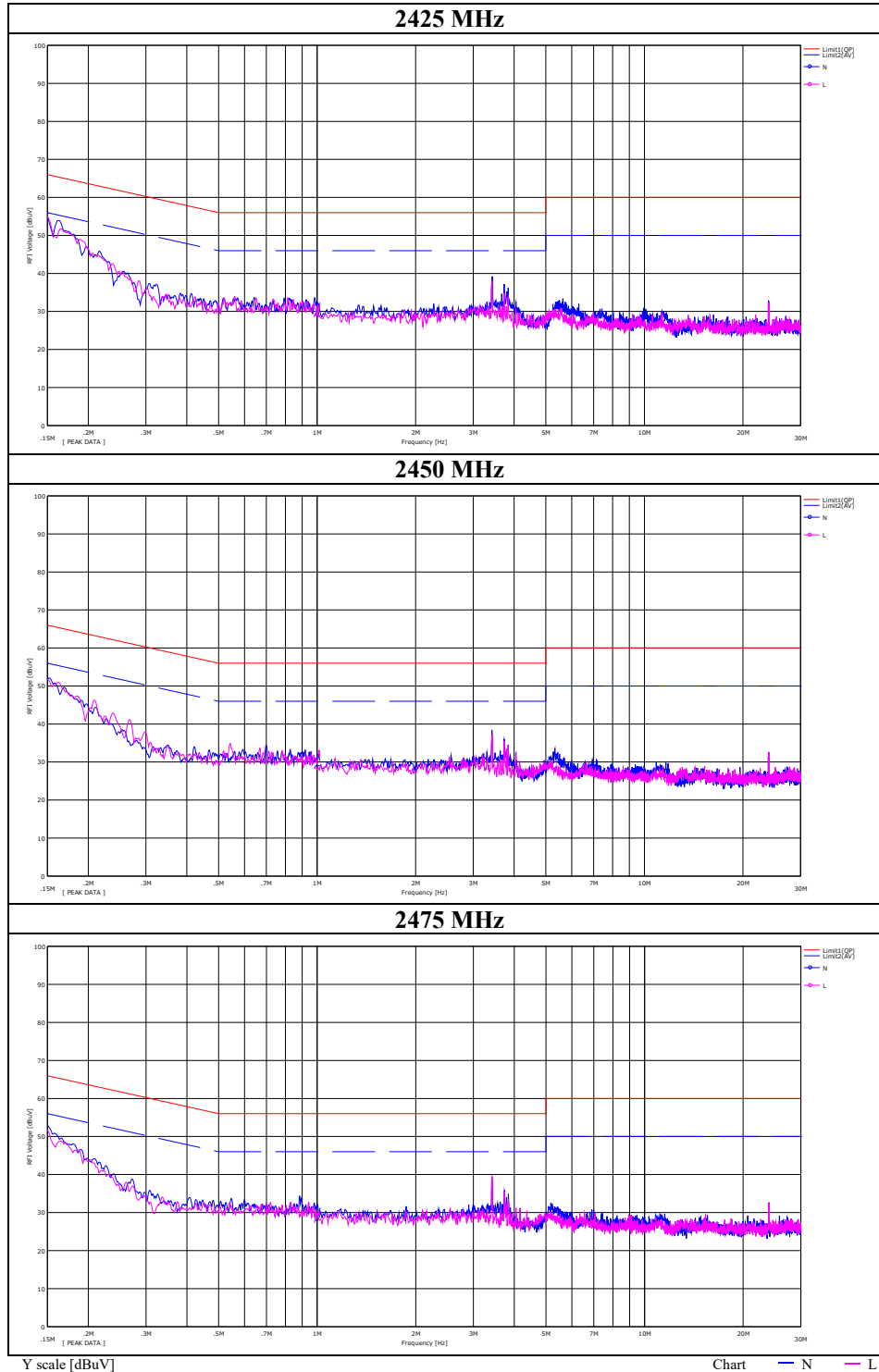
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Facsimile : +81 596 24 8124

Conducted Emission

Report No. 13140333H
Test place Ise EMC Lab. No.4 Semi Anechoic Chamber
Date February 28, 2020
Temperature / Humidity 23 deg. C / 28 % RH
Engineer Yuta Moriya
Mode Tx



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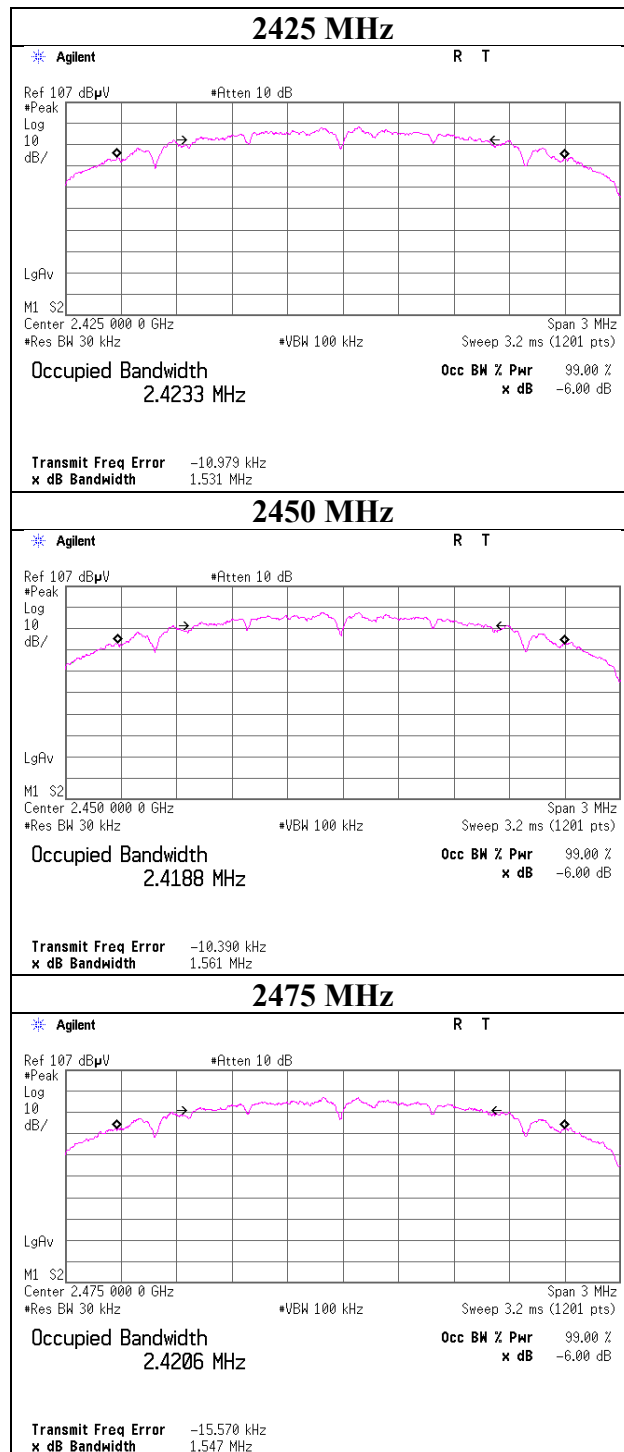
Facsimile : +81 596 24 8124

6 dB Bandwidth and 99 % Occupied Bandwidth

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx

Mode	Frequency [MHz]	99% Occupied Bandwidth [kHz]	6dB Bandwidth [MHz]	Limit for 6dB Bandwidth [MHz]
Zig bee	2425	2423.3	1.6070	> 0.5000
	2450	2418.8	1.6100	> 0.5000
	2475	2420.6	1.6030	> 0.5000

99%Occupied Bandwidth



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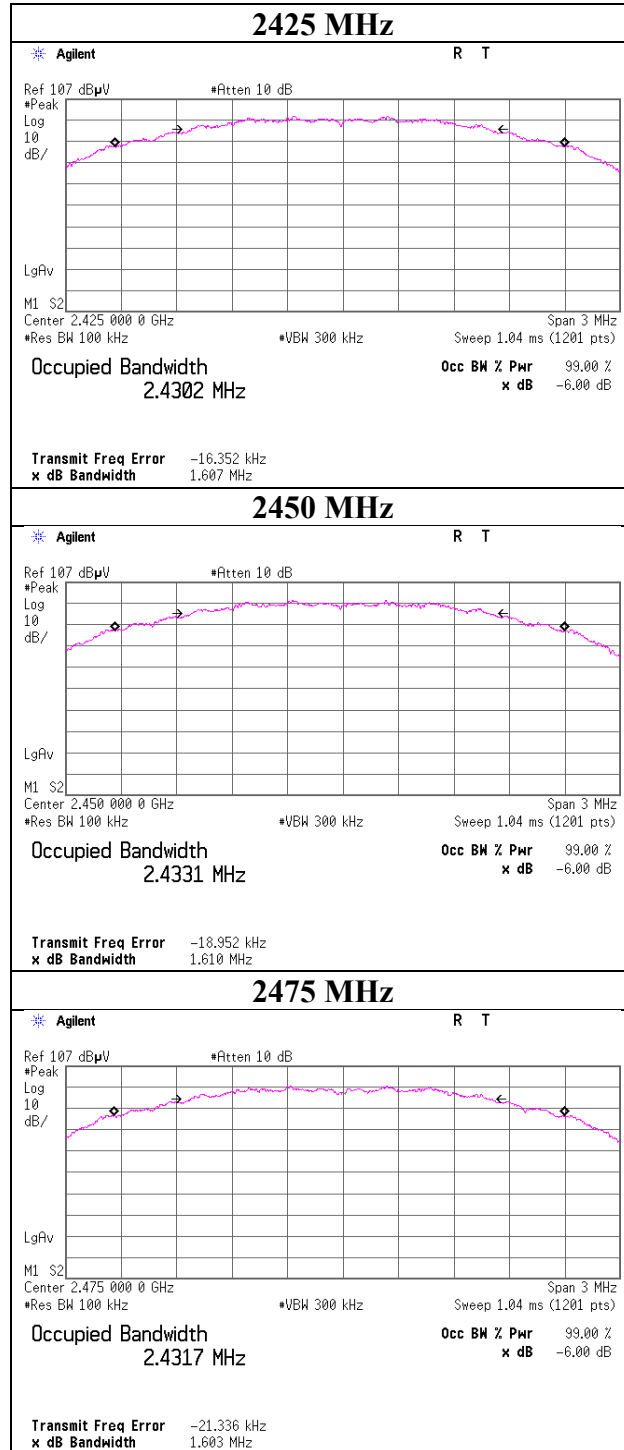
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6dB Bandwidth



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Maximum Peak Output Power

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
				Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
2425	-4.87	2.91	10.04	8.08	6.43	30.00	1000	21.92	2.00	10.08	10.19	36.02	4000	25.94
2450	-5.30	2.92	10.04	7.66	5.83	30.00	1000	22.34	2.00	9.66	9.25	36.02	4000	26.36
2475	-6.04	2.93	10.04	6.93	4.93	30.00	1000	23.07	2.00	8.93	7.82	36.02	4000	27.09

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

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Average Output Power
(Reference data for SAR testing)

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020 March 3, 2020
Temperature / Humidity 23 deg. C / 33 % RH 24 deg. C / 48 % RH
Engineer Yuichiro Yamazaki Ryota Yamanaka
Mode Tx

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
				[dBm]	[mW]		[dBm]	[mW]
2425	6.48	1.50	0.00	7.98	6.28	0.00	7.98	6.28
2450	5.87	1.50	0.00	7.37	5.46	0.00	7.37	5.46
2475	5.24	1.50	0.00	6.74	4.72	0.00	6.74	4.72

Sample Calculation:

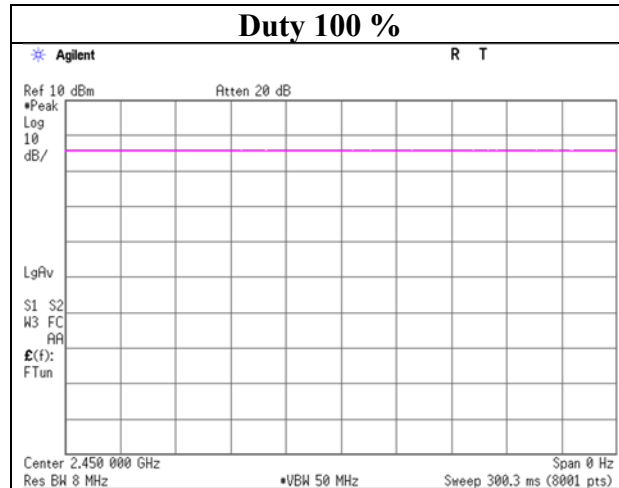
Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Result (Burst power average) = Time average + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.

Burst rate confirmation

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx



* Since the burst rate is not different between the channels, the data has been obtained on the representative channel.

Radiated Spurious Emission

Report No.	13140333H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.4	No.4	No.4
Date	February 27, 2020	February 28, 2020	February 28, 2020
Temperature / Humidity	24 deg. C / 30 % RH	22 deg. C / 33 % RH	23 deg. C / 28 % RH
Engineer	Hiroyuki Furutaka	Hiroyuki Furutaka	Yuta Moriya
	(1 GHz - 10 GHz)	(10 GHz - 26.5 GHz)	(Below 1 GHz)
Mode	Tx 2425 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	40.000	QP	40.5	14.9	7.6	30.4	-	32.6	40.0	7.4	
Hori.	110.000	QP	24.8	11.9	8.5	30.2	-	15.0	43.5	28.5	
Hori.	150.000	QP	23.8	14.9	8.9	29.9	-	17.7	43.5	25.8	
Hori.	300.000	QP	22.7	13.5	10.1	29.2	-	17.2	46.0	28.8	
Hori.	400.000	QP	22.7	15.8	10.8	29.7	-	19.5	46.0	26.5	
Hori.	900.000	QP	20.8	22.0	13.4	28.4	-	27.8	46.0	18.2	
Hori.	2390.000	PK	44.6	27.9	5.9	31.9	-	46.5	73.9	27.4	
Hori.	4850.000	PK	42.3	31.7	8.1	31.2	-	50.8	73.9	23.1	
Hori.	7275.000	PK	41.3	36.3	9.5	32.4	-	54.7	73.9	19.2	Floor noise
Hori.	9700.000	PK	42.8	38.2	10.4	32.8	-	58.6	73.9	15.3	Floor noise
Hori.	2390.000	AV	35.3	27.9	5.9	31.9	-	37.2	53.9	16.7	
Hori.	4850.000	AV	33.5	31.7	8.1	31.2	-	42.1	53.9	11.9	
Hori.	7275.000	AV	33.3	36.3	9.5	32.4	-	46.7	53.9	7.2	Floor noise
Hori.	9700.000	AV	31.8	38.2	10.4	32.8	-	47.6	53.9	6.3	Floor noise
Vert.	40.000	QP	32.9	14.9	7.6	30.4	-	25.0	40.0	15.0	
Vert.	110.000	QP	24.4	11.9	8.5	30.2	-	14.7	43.5	28.9	
Vert.	150.000	QP	23.9	14.9	8.9	29.9	-	17.8	43.5	25.7	
Vert.	300.000	QP	22.7	13.5	10.1	29.2	-	17.2	46.0	28.8	
Vert.	400.000	QP	22.7	15.8	10.8	29.7	-	19.5	46.0	26.5	
Vert.	900.000	QP	20.7	22.0	13.4	28.4	-	27.8	46.0	18.2	
Vert.	2390.000	PK	43.3	27.9	5.9	31.9	-	45.2	73.9	28.7	
Vert.	4850.000	PK	43.9	31.7	8.1	31.2	-	52.5	73.9	21.4	
Vert.	7275.000	PK	42.3	36.3	9.5	32.4	-	55.8	73.9	18.1	Floor noise
Vert.	9700.000	PK	42.8	38.2	10.4	32.8	-	58.6	73.9	15.3	Floor noise
Vert.	2390.000	AV	34.5	27.9	5.9	31.9	-	36.4	53.9	17.5	
Vert.	4850.000	AV	35.8	31.7	8.1	31.2	-	44.3	53.9	9.6	
Vert.	7275.000	AV	33.9	36.3	9.5	32.4	-	47.3	53.9	6.6	Floor noise
Vert.	9700.000	AV	32.0	38.2	10.4	32.8	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2425.000	PK	96.1	27.8	5.9	31.9	98.0	-	-	Carrier
Hori.	2400.000	PK	36.9	27.9	5.9	31.9	38.8	78.0	39.2	
Vert.	2425.000	PK	93.1	27.8	5.9	31.9	95.0	-	-	Carrier
Vert.	2400.000	PK	35.5	27.9	5.9	31.9	37.4	75.0	37.6	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5dB

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Ise EMC Lab.

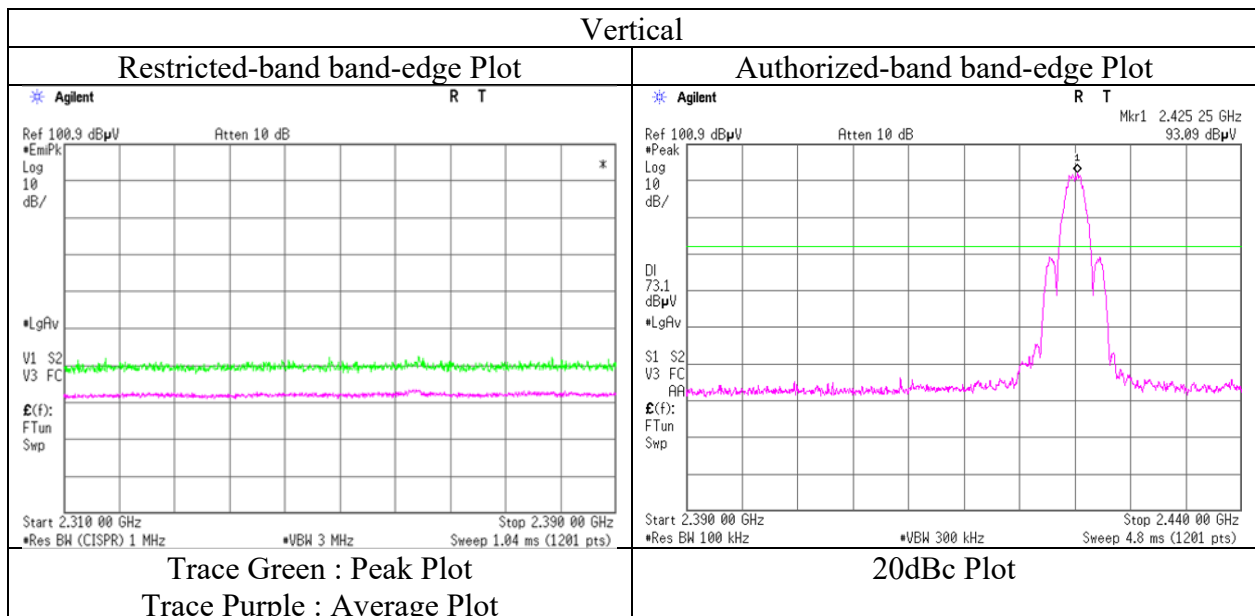
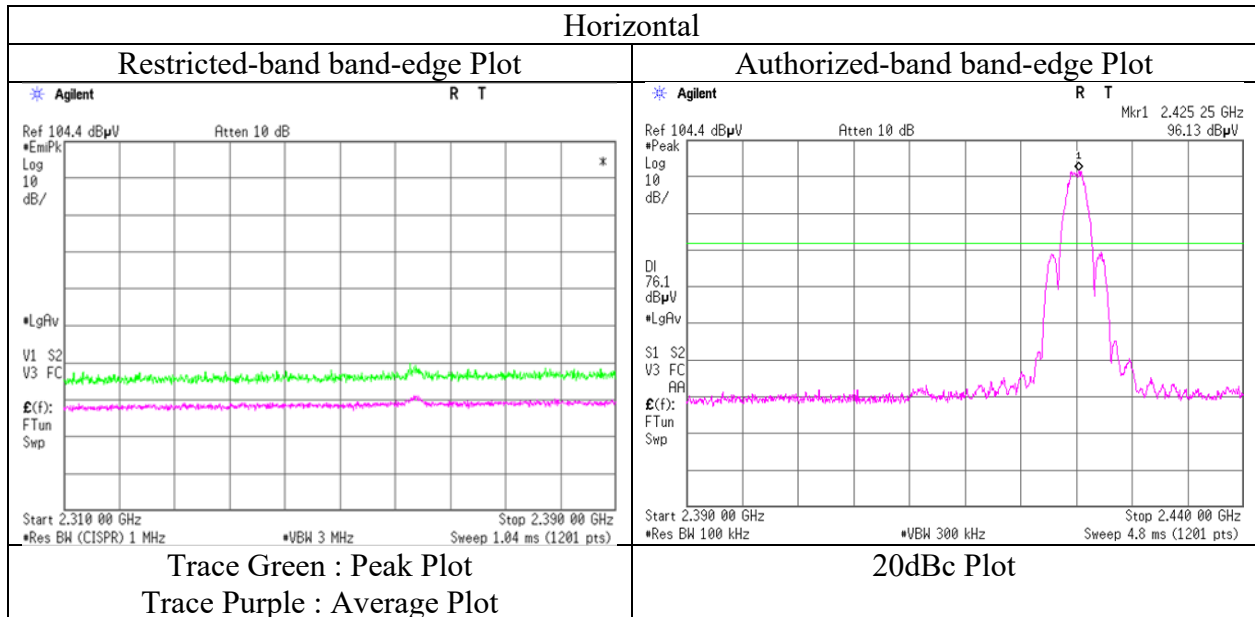
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13140333H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.4
Date	February 27, 2020
Temperature / Humidity	24 deg. C / 30 % RH
Engineer	Hiroyuki Furutaka
	(1 GHz - 10 GHz)
Mode	Tx 2425 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

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Radiated Spurious Emission

Report No.	13140333H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.4	No.4	No.4
Date	February 27, 2020	February 28, 2020	February 28, 2020
Temperature / Humidity	24 deg. C / 30 % RH	22 deg. C / 33 % RH	23 deg. C / 28 % RH
Engineer	Hiroyuki Furutaka (1 GHz - 10 GHz)	Hiroyuki Furutaka (10 GHz - 26.5 GHz)	Yuta Moriya (Below 1 GHz)
Mode	Tx 2450 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	40.000	QP	40.5	14.9	7.6	30.4	-	32.6	40.0	7.4	
Hori.	110.000	QP	24.7	11.9	8.5	30.2	-	15.0	43.5	28.5	
Hori.	150.000	QP	23.2	14.9	8.9	29.9	-	17.1	43.5	26.4	
Hori.	300.000	QP	22.7	13.5	10.1	29.2	-	17.2	46.0	28.8	
Hori.	400.000	QP	22.7	15.8	10.8	29.7	-	19.5	46.0	26.5	
Hori.	900.000	QP	20.8	22.0	13.4	28.4	-	27.9	46.0	18.1	
Hori.	4900.000	PK	42.2	31.6	7.3	31.2	-	49.9	73.9	24.0	
Hori.	7350.000	PK	42.7	36.6	8.8	32.5	-	55.5	73.9	18.4	Floor noise
Hori.	9800.000	PK	41.9	38.3	9.8	32.9	-	57.1	73.9	16.8	Floor noise
Hori.	4900.000	AV	34.7	31.6	7.3	31.2	-	42.4	53.9	11.5	
Hori.	7350.000	AV	34.3	36.6	8.8	32.5	-	47.2	53.9	6.7	Floor noise
Hori.	9800.000	AV	32.3	38.3	9.8	32.9	-	47.5	53.9	6.4	Floor noise
Vert.	40.000	QP	32.9	14.9	7.6	30.4	-	25.0	40.0	15.1	
Vert.	110.000	QP	24.4	11.9	8.5	30.2	-	14.7	43.5	28.8	
Vert.	150.000	QP	23.8	14.9	8.9	29.9	-	17.7	43.5	25.8	
Vert.	300.000	QP	22.5	13.5	10.1	29.2	-	17.0	46.0	29.0	
Vert.	400.000	QP	22.6	15.8	10.8	29.7	-	19.4	46.0	26.6	
Vert.	900.000	QP	20.7	22.0	13.4	28.4	-	27.8	46.0	18.2	
Vert.	4900.000	PK	44.0	31.6	7.3	31.2	-	51.7	73.9	22.3	
Vert.	7350.000	PK	43.3	36.6	8.8	32.5	-	56.1	73.9	17.8	Floor noise
Vert.	9800.000	PK	42.2	38.3	9.8	32.9	-	57.4	73.9	16.5	Floor noise
Vert.	4900.000	AV	36.2	31.6	7.3	31.2	-	43.8	53.9	10.1	
Vert.	7350.000	AV	34.2	36.6	8.8	32.5	-	47.0	53.9	6.9	Floor noise
Vert.	9800.000	AV	32.6	38.3	9.8	32.9	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

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Ise EMC Lab.

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Telephone : +81 596 24 8999

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Radiated Spurious Emission

Report No.	13140333H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.4	No.4	No.4
Date	February 27, 2020	February 28, 2020	February 28, 2020
Temperature / Humidity	24 deg. C / 30 % RH	22 deg. C / 33 % RH	23 deg. C / 28 % RH
Engineer	Hiroyuki Furutaka (1 GHz - 10 GHz)	Hiroyuki Furutaka (10 GHz - 26.5 GHz)	Yuta Moriya (Below 1 GHz)
Mode	Tx 2475 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	40.000	QP	40.6	14.9	7.6	30.4	-	32.6	40.0	7.4	
Hori.	110.000	QP	24.8	11.9	8.5	30.2	-	15.0	43.5	28.5	
Hori.	150.000	QP	23.4	14.9	8.9	29.9	-	17.3	43.5	26.2	
Hori.	300.000	QP	22.8	13.5	10.1	29.2	-	17.3	46.0	28.7	
Hori.	400.000	QP	22.8	15.8	10.8	29.7	-	19.6	46.0	26.4	
Hori.	900.000	QP	20.4	22.0	13.4	28.4	-	27.5	46.0	18.5	
Hori.	2483.500	PK	46.8	27.7	6.0	31.8	-	48.6	73.9	25.3	
Hori.	4950.000	PK	42.2	31.6	7.3	31.2	-	49.9	73.9	24.0	
Hori.	7425.000	PK	42.3	36.6	8.8	32.5	-	55.1	73.9	18.9	Floor noise
Hori.	9900.000	PK	42.3	38.5	9.8	33.0	-	57.6	73.9	16.3	Floor noise
Hori.	2483.500	AV	38.2	27.7	6.0	31.8	-	40.1	53.9	13.8	
Hori.	4950.000	AV	32.3	31.6	7.3	31.2	-	40.0	53.9	13.9	
Hori.	7425.000	AV	31.5	36.6	8.8	32.5	-	44.3	53.9	9.6	Floor noise
Hori.	9900.000	AV	31.8	38.5	9.8	33.0	-	47.1	53.9	6.8	Floor noise
Vert.	40.000	QP	33.1	14.9	7.6	30.4	-	25.2	40.0	14.8	
Vert.	110.000	QP	24.5	11.9	8.5	30.2	-	14.8	43.5	28.7	
Vert.	150.000	QP	23.9	14.9	8.9	29.9	-	17.8	43.5	25.7	
Vert.	300.000	QP	23.0	13.5	10.1	29.2	-	17.4	46.0	28.6	
Vert.	400.000	QP	22.8	15.8	10.8	29.7	-	19.6	46.0	26.4	
Vert.	900.000	QP	20.8	22.0	13.4	28.4	-	27.9	46.0	18.1	
Vert.	2483.500	PK	44.7	27.7	6.0	31.8	-	46.6	73.9	27.3	
Vert.	4950.000	PK	43.0	31.6	7.3	31.2	-	50.7	73.9	23.2	
Vert.	7425.000	PK	42.2	36.6	8.8	32.5	-	55.0	73.9	19.0	Floor noise
Vert.	9900.000	PK	42.4	38.5	9.8	33.0	-	57.7	73.9	16.2	Floor noise
Vert.	2483.500	AV	36.0	27.7	6.0	31.8	-	37.9	53.9	16.0	
Vert.	4950.000	AV	35.0	31.6	7.3	31.2	-	42.7	53.9	11.2	
Vert.	7425.000	AV	33.4	36.6	8.8	32.5	-	46.2	53.9	7.8	Floor noise
Vert.	9900.000	AV	31.6	38.5	9.8	33.0	-	47.0	53.9	6.9	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.0 m / 3.0 m) = 2.5 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

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Ise EMC Lab.

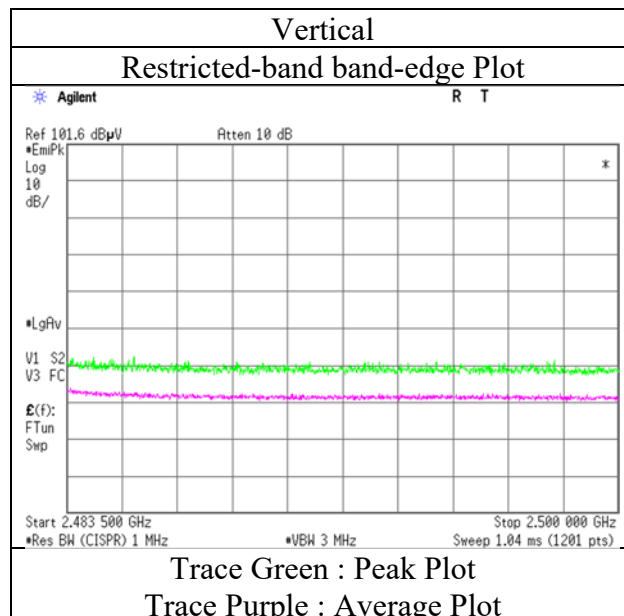
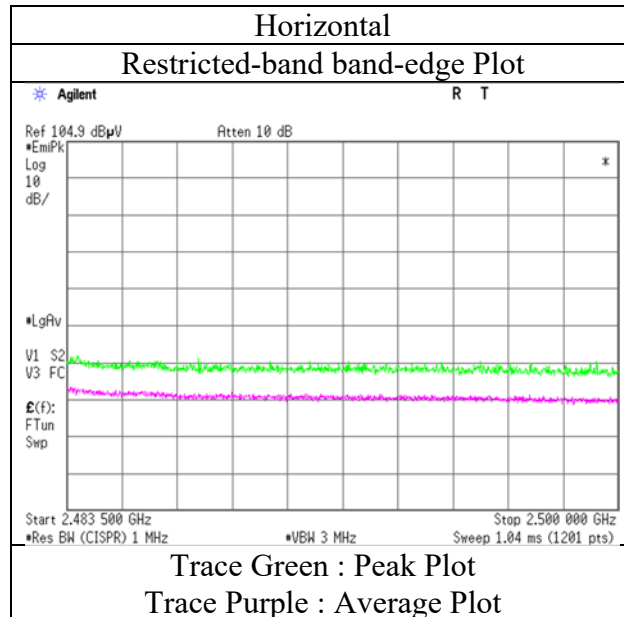
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	13140333H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.4
Date	February 27, 2020
Temperature / Humidity	24 deg. C / 30 % RH
Engineer	Hiroyuki Furutaka (1 GHz - 10 GHz)
Mode	Tx 2475 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

UL Japan, Inc.

Ise EMC Lab.

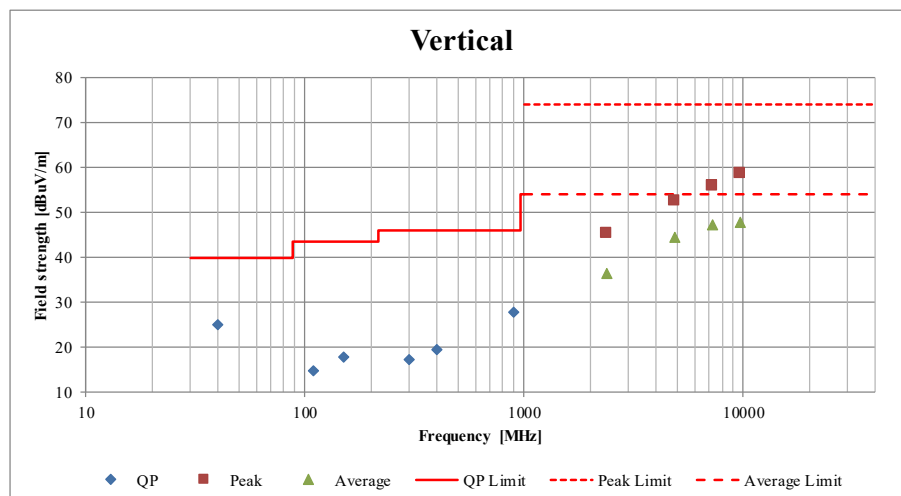
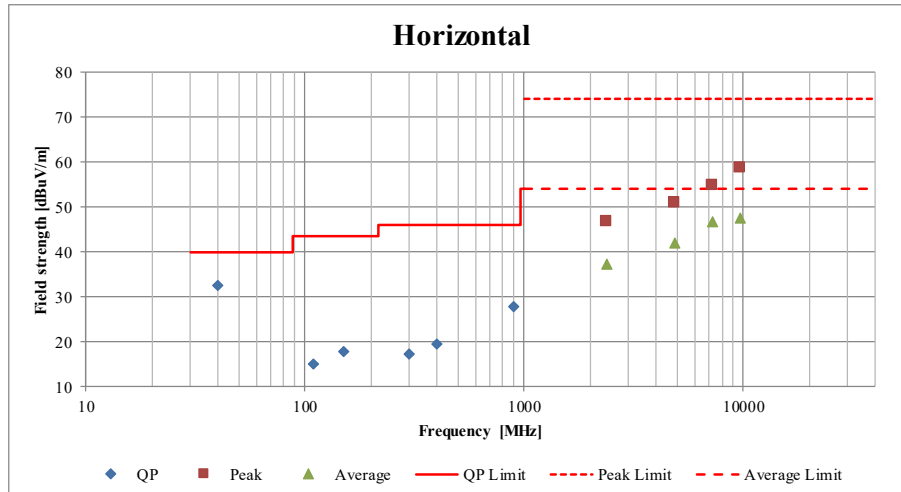
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Radiated Spurious Emission
(Plot data, Worst case)

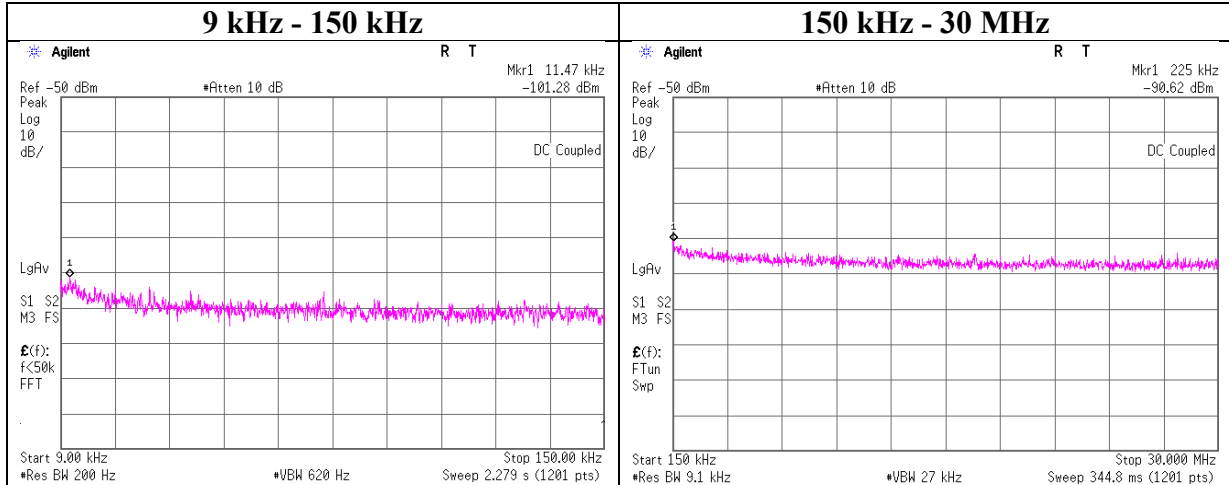
Report No.	13140333H	No.4	No.4
Test place	Ise EMC Lab.	February 27, 2020	February 28, 2020
Semi Anechoic Chamber	No.4	February 28, 2020	February 28, 2020
Date	February 27, 2020	22 deg. C / 33 % RH	23 deg. C / 28 % RH
Temperature / Humidity	24 deg. C / 30 % RH	Hiroyuki Furutaka	Yuta Moriya
Engineer	Hiroyuki Furutaka	(1 GHz - 10 GHz)	(10 GHz - 26.5 GHz)
Mode	Tx 2425 MHz		Below 1GHz



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

Conducted Spurious Emission

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx 2425 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.47	-101.28	1.54	9.85	2.0	1	-87.9	300	6.0	-26.6	46.4	73.0	
225.00	-90.62	1.72	9.89	2.0	1	-77.0	300	6.0	-15.8	20.5	36.3	

$E [dBuV/m] = EIRP [dBm] - 20 \log (Distance [m]) + Ground\ bounce [dB] + 104.8 [dBuV/m]$

$EIRP[dBm] = Reading [dBm] + Cable\ loss [dB] + Attenuator\ Loss [dB] + Antenna\ gain [dBi] + 10 * \log (N)$

N: Number of output

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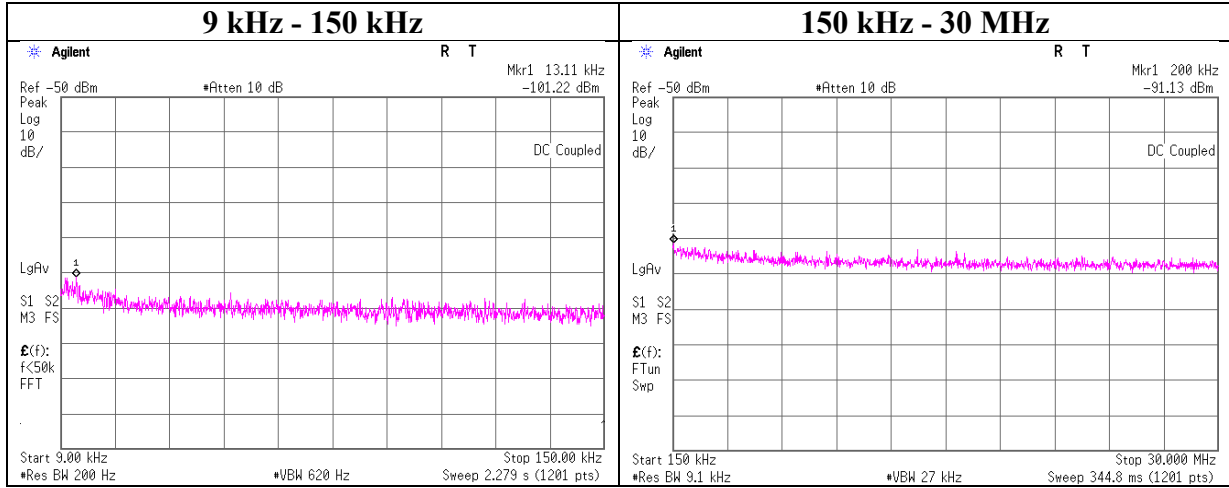
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Conducted Spurious Emission

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx 2450 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
13.11	-101.22	1.55	9.85	2.0	1	-87.8	300	6.0	-26.6	45.2	71.8	
200.00	-91.13	1.70	9.88	2.0	1	-77.6	300	6.0	-16.3	21.5	37.8	

$E [dBuV/m] = EIRP [dBm] - 20 \log (Distance [m]) + Ground\ bounce [dB] + 104.8 [dBuV/m]$

$EIRP [dBm] = Reading [dBm] + Cable\ loss [dB] + Attenuator\ Loss [dB] + Antenna\ gain [dBi] + 10 * \log (N)$

N: Number of output

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Ise EMC Lab.

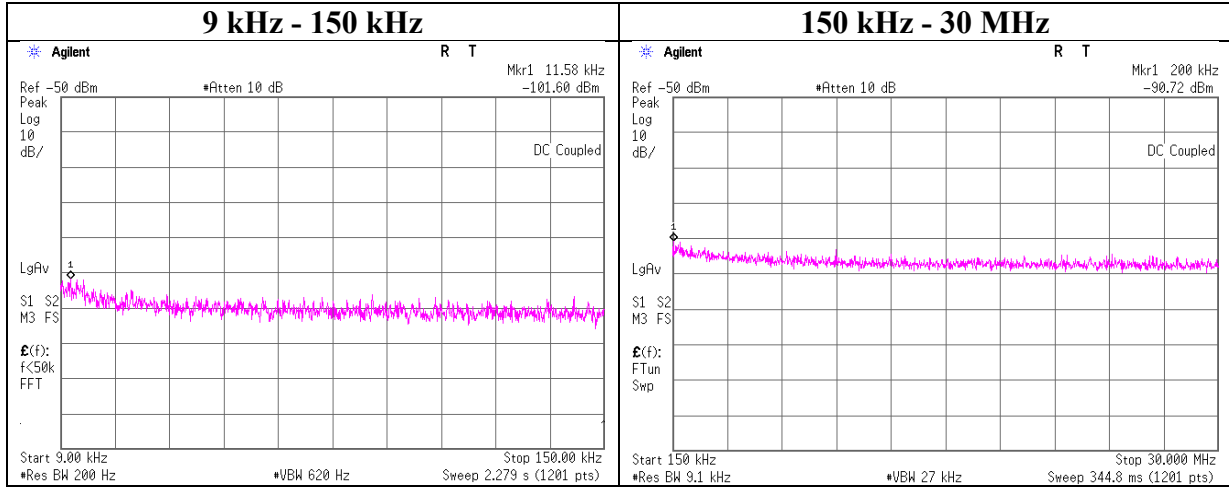
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Conducted Spurious Emission

Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx 2475 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.58	-101.60	1.54	9.85	2.0	1	-88.2	300	6.0	-27.0	46.3	73.3	
200.00	-90.72	1.70	9.88	2.0	1	-77.1	300	6.0	-15.9	21.5	37.4	

$E [dBuV/m] = EIRP [dBm] - 20 \log (Distance [m]) + Ground\ bounce [dB] + 104.8 [dBuV/m]$

$EIRP [dBm] = Reading [dBm] + Cable\ loss [dB] + Attenuator\ Loss [dB] + Antenna\ gain [dBi] + 10 * \log (N)$

N: Number of output

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Power Density

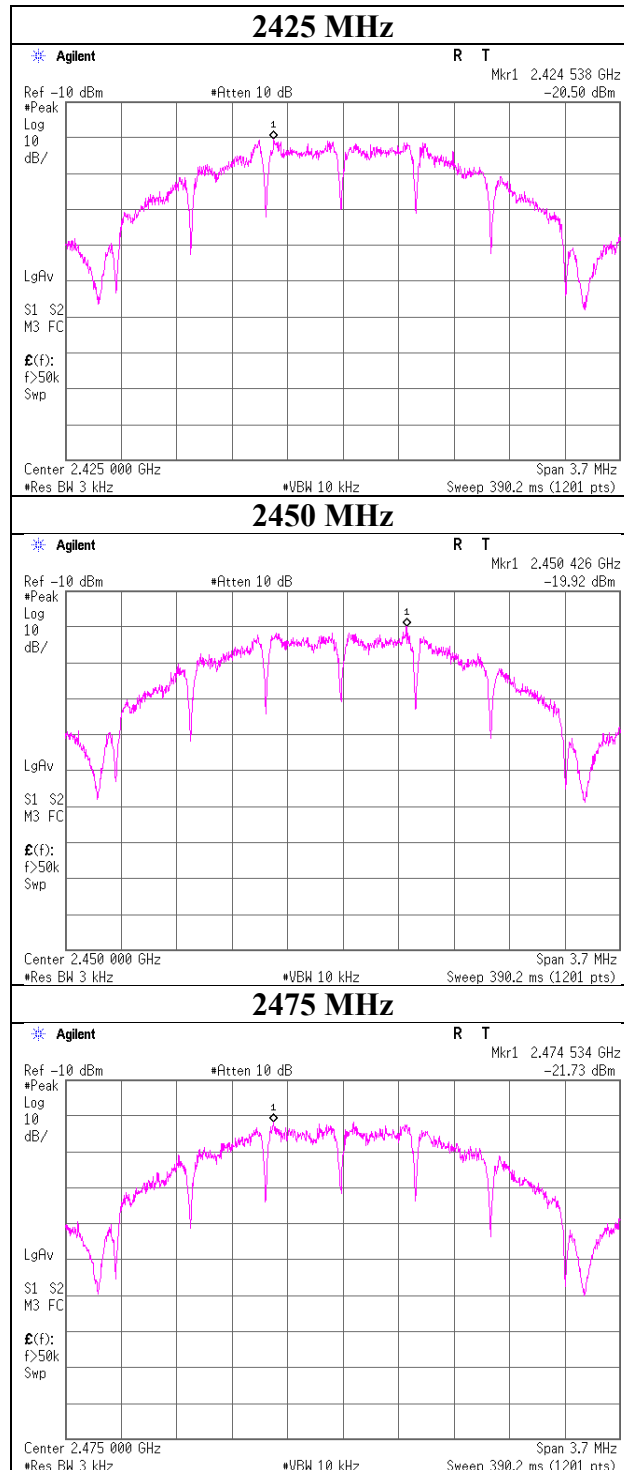
Report No. 13140333H
Test place Ise EMC Lab. No.10 Measurement Room
Date February 18, 2020
Temperature / Humidity 23 deg. C / 33 % RH
Engineer Yuichiro Yamazaki
Mode Tx

Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
2425	-20.50	2.91	10.04	-7.55	8.00	15.55
2450	-19.92	2.92	10.04	-6.96	8.00	14.96
2475	-21.73	2.93	10.04	-8.76	8.00	16.76

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Power Density



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APPENDIX 2: Test instruments

Test equipment

Test Item	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
AT	MAT-10	141156	Attenuator(10dB)	Weinschel Corp.	2	BL1173	11/07/2019	12
CE	MCC-113	141217	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM141/421-010/sucoform141-PE/RFM-E121(SW)	-/04178	06/18/2019	12
CE	MAT-67	141248	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	12/02/2019	12
RE	MLA-23	141267	Logperiodic Antenna (200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-192	08/24/2019	12
AT	MAT-22	141269	Attenuator(10dB) 1-18GHz	Orient Microwave	BX10-0476-00	-	03/26/2019	12
RE	MHF-26	141296	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	002	09/11/2019	12
AT	MCC-67	141329	Microwave Cable 1G-40GHz	Suhner	SUCOFLEX102	28635/2	04/03/2019	12
RE	MAT-34	141331	Attenuator(6dB)	TME	UFA-01	-	02/05/2020	12
CE	MLS-23	141357	LISN(AMN)	Schwarzbeck	NSLK8127	8127-729	07/05/2019	12
RE	MCC-50	141397	Coaxial Cable	UL Japan	-	-	06/18/2019	12
RE	MCC-141	141412	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	06/17/2019	12
RE	MBA-05	141425	Biconical Antenna	Schwarzbeck	VHA9103+BBA9106	1302	08/24/2019	12
RE	MHA-17	141506	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170307	10/08/2019	12
RE	MHA-21	141508	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	09/26/2019	12
CE	MMM-10	141545	DIGITAL HiTESTER	HIOKI	3805	51201148	01/06/2020	12
CE/RE	MOS-15	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	01/07/2020	12
RE	MPA-09	141578	Pre Amplifier	Keysight Technologies Inc	8447D	2944A10845	09/06/2019	12
RE	MPA-12	141581	MicroWave System Amplifier	Keysight Technologies Inc	83017A	650	10/16/2019	12
AT	MPM-08	141805	Power Meter	ANRITSU	ML2495A	6K00003338	10/03/2019	12
AT	MPSE-11	141840	Power sensor	ANRITSU	MA2411B	11737	10/03/2019	12
AT	MSA-14	141901	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY48250080	10/06/2019	12
CE/RE	MSA-15	141902	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46187105	10/09/2019	12
RE	MTW-04	141946	Torque wrench	Huber+Suhner	74 Z-0-0-21	17129	01/23/2018	36
CE/RE	MTR-08	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/02/2019	12
CE	MAEC-04	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/28/2018	24
RE	MAEC-04-SVSWR	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/04/2019	24

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item: CE: Conducted Emission test
RE: Radiated Emission test
AT: Antenna Terminal Conducted test

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